

Notice of References Cited	Application/Control No. 10/000,089	Applicant(s)/Patent Under Reexamination HIRAIDE ET AL.	
	Examiner John P Trimmings	Art Unit 2133	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,612,963	03-1997	Koenemann et al.	714/739
	B	US-6,061,818	05-2000	Touba et al.	714/739
	C	US-2002/0093356	07-2002	Williams et al.	324/765
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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	U	Jas et al., "Hybrid BIST Based on Weighted Pseudo-Random Testing: a New Test Resource Partitioning Scheme", IEEE Proceedings, VTS 2001, 29 April - 3 May 2001, pp 2-8.
	V	Barnhart et al., "OPMISR: The Foundation for Compressed ATPG Vectors", IEEE Proceedings TC 2001, 30 October - 1 November 2001.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.